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Electrical Detection of Singlet Fission in Single Crystal Tetracene Transistors

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Abstract

We present the electrical detection of singlet fission in tetracene by using a field-effect transistor (FET). Singlet fission is a photo-induced spin-dependent process, yielding two triplet excitons from the absorption of a single photon. In this study, we engineered a more deterministic platform composed of an organic single crystal FET rather than amorphous or polycrystalline FETs to elucidate spin-dependent processes under magnetic fields. Despite the unipolar operation and relatively high mobility of single crystal tetracene FETs, we were able to manipulate spin dependent processes to detect magnetoconductance (MC) at room temperature by illuminating the FETs and tuning the bias voltage to adjust majority charge carrier density and trap occupancy. In considering the crystalline direction and magnetic field interactions in tetracene, we show the MC response observed in tetracene FETs to be the result of the singlet fission process.

Graphical Abstract

Keywords

single crystalline organic semiconductors; singlet fission; magnetoconductance; organic field effect transistors

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ASSOCIATED CONTENT

Supporting Information. Figures S1 – S8 as described in the text, further analysis on electrical and magnetoconductance measurements of the devices, crystal axis measurement of tetracene, further details on mathematical calculation, and further discussion of proposed theoretical models. This material is available free of charge via the Internet at <http://pubs.acs.org>.

Understanding and harnessing spin-related phenomena and spin-dependent processes remain a key challenge to realizing applications for organic semiconductor based device technology.^{1–4} Spin-dependent processes play a crucial role in determining and enhancing the efficiency of organic-based devices such as organic light emitting diodes (OLEDs) and organic photovoltaics (OPVs).^{3–7} Among the most widely used methods for studying spin-dependent processes in organic-based devices is the application of an externally applied magnetic field.^{3,4, 7–11} An applied external magnetic field is known to perturb the ratio of singlet and triplet excited states, resulting in changes of the electronic and optoelectronic properties of the organic-based devices such as electrical resistance and electroluminescence.^{3,4} However, the physical mechanisms behind spin-dependent processes controlling (opto-) electronic properties under magnetic fields remain a topic of scientific debate.⁴ This is partly due to the experimental studies conducted to date which have largely been based on devices or test structures made from amorphous or polycrystalline thin films of organic semiconductors.⁴ Previous studies have favored structurally disordered organic systems because it was suggested that more charge carrier trap sites and longer time between charge carrier hops (consistent with a low charge carrier mobility) enhance the aforementioned magnetic field effects by providing polaron pairs with enough time to interact with the local random hyperfine fields present in organic semiconductors.¹²

Intrigued by the lack of consensus on the theories describing the phenomena observed in thin film based organic devices, we engineered device test structures with a higher degree of structural order by using organic single crystals. The better-defined crystallographic directions and transport pathways provide a test platform which may be more deterministic for elucidating spin-dependent processes under magnetic fields. Specifically, we investigated unipolar (hole transport) field effect transistors (FETs) made from single crystals of tetracene. Tetracene, a widely studied small molecule organic semiconductor, is particularly interesting because it is known to exhibit an uncommon spin-dependent process: singlet fission.^{9, 13–18} Unlike intersystem crossing of a two-charge carrier system induced by either hyperfine interaction or spin-orbit coupling which creates a triplet from a singlet exciton by reversing the spin of one charge carrier,⁴ singlet fission involves four charge carriers of two molecules, thus generating two triplets from a singlet without requiring any spin reversal.^{19–22} We found that our single crystal tetracene FETs produced not only a typical monotonic change of electrical resistance under magnetic fields when illuminated, but also peculiar features not previously reported on in detail. By considering the crystal orientation of tetracene and related dipolar and Zeeman interactions, we show that the features are byproducts of singlet fission/triplet fusion processes. In addition, in the process of elucidating the spin-dependent processes related to singlet fission, we engineered a device structure to achieve a few percent of magnetoresistance in our photoactive field-effect transistors at room temperature, which can contribute to the development of technology of multi-functional electronic devices such as light-controlled FET/ magnetic field sensor.^{23, 24}

RESULTS AND DISCUSSION

The device structure of our single crystal tetracene FETs is illustrated in the inset of Figure 1a along with electrical and magnetic field measurement configurations (see Experimental Methods section). Plotted in Figure 1a is the electrical characteristics of a tetracene FET

fabricated with Cytop gate dielectric (see Methods section) measured under broadband illumination and in the dark. The FETs display p-type conduction behavior, *i.e.* the majority charge carriers are holes. When the FETs are illuminated, an increase in drain current (I_D) is observed; especially, in the sub-threshold (low gate bias, V_{GS}) regime. Previous reports suggested the photo-enhanced current can be produced by charge carriers generated at illuminated electrodes as well as in the bulk of the tetracene crystal.²⁵ The contribution of the bulk crystal to photocurrent has been attributed to the creation of triplet excitons in tetracene *via* the singlet fission process $S_0 + S_1 \rightarrow T_1 + T_1$. Where S_0 represents the singlet ground state and S_1 and T_1 represent the first excited singlet and triplet state, respectively.^{26–28} The increase in the population of triplet excitons is believed to facilitate the de-trapping of localized charge carriers *via* the process $T_1 + n^* \rightarrow S_0 + n$. Triplet excitons can also dissociate into secondary charge carriers as the result of their interaction with trapped (or free) charge carriers as described by the process $T_1 + n (n^*) \rightarrow e + h + n (n^*)$, where $n (n^*)$, e , and h represent a free (trapped) charge carrier, an electron, and a hole.²⁸

The magnetic field dependence of I_D was measured by applying an external in-plane magnetic field as depicted in the inset of Figure 1a. Plotted in the inset to Figure 1b is the measured magnetoconductance (MC) of a tetracene FET fabricated with Cytop gate dielectric in the dark and under a broadband illumination intensity of 34 mW/cm². The FET has a channel length of 50 μ m and was biased with constant gate-source (V_{GS}) and drain-source (V_{DS}) voltages. MC is defined as $[I_D(B) - I_D(B = 0)] / I_D(B = 0)$ where B is the magnitude of the applied magnetic field. The external magnetic field was swept between –230 mT and 230 mT. For our tetracene FETs measured under illumination, we found that the magnitude of the I_D ($|I_D|$) decreased with increasing external magnetic field; showing a negative MC response. When measured in the dark, no change in the I_D was measured with an applied magnetic field, as expected for our FETs which exhibit unipolar operation and have a higher mobility (~ 0.2 cm² V^{–1} s^{–1}, see Supporting Information) than most thin film based devices.^{4, 12} The change in the I_D with magnetic field when illuminated is attributed to the creation of electron-hole pairs and minority charge carriers.⁴

Although a broad band light source was used for the experiments described here, we were able to define the approximate spectral response of the observed MC by using filters (see Supporting Information). We found that the spectral range of ~ 350 nm to ~ 615 nm produces MC in our single crystalline tetracene FETs. The spectral range agrees with that of previous reports of photocurrent in a magnetic field²⁹ for tetracene, as well as, the ground-state light absorption spectrum of tetracene.^{30, 31} Because the photocurrent is related to the creation of triplet excitons in tetracene *via* the singlet fission process, a negative MC is consistent with the reduction of photo-generated triplet population under magnetic fields.²⁸ This is likely caused by the splitting of triplet energy levels by Zeeman effect.^{4, 7, 27}

Plotted in Figure 1b is the magnitude of the MC ($|MC|$) at ~ 200 mT *versus* V_{GS} measured in the dark and under illumination. We found a large drop in the $|MC|$ followed by saturation as the magnitude of V_{GS} ($|V_{GS}|$) increased above the threshold voltage of the device. As $|V_{GS}|$ increases, $|I_D|$ is expected to increase because the charge carrier density increases in the conducting channel as a result of the Fermi level in tetracene shifting towards the mobility edge. With increasing $|V_{GS}|$, in gap donor states (traps) are emptied and the rate of triplet

exciton quenching by trapped charges diminishes. Our data imply that triplet exciton quenching by trapped charge has a significant effect on MC in tetracene FETs.

Despite the observation of MC in organic FETs (OFETs) fabricated with Cytop gate dielectric, further studies on magnetic-field dependent phenomena in single crystalline tetracene were limited due to low MC signals. However, by changing dielectric interface to the silicon dioxide (SiO_2) we are able to alter the interface trap density and enhance our MC signal without introducing grain boundaries or disorder in the tetracene crystal (see Figure S2). Plotted in Figure 2a is the electrical characteristics of a single crystal tetracene FETs fabricated with SiO_2 gate dielectric and measured under illumination and in the dark. Similar to tetracene FETs fabricated with Cytop gate dielectric, the FETs fabricated with SiO_2 gate dielectric display p-type conduction behavior and an increase in drain current with illumination, especially in the sub threshold regime (at low V_{GS}). The magnetic field dependence of I_{D} in FETs prepared on SiO_2 gate dielectric was measured and showed a $10 \times$ increase in MC signal under illumination compared to FETs prepared on Cytop gate dielectric, see Figure 2b. Cytop dielectric provided better charge carrier transport/mobility characteristics, but SiO_2 dielectric offered superior MC effects. No change in the I_{D} with an external magnetic field was observed when measured in the dark, consistent with the previous observations for FETs fabricated with Cytop gate dielectric.

The inset to Figure 3a shows the measured MC measured in the dark and under an illumination intensity of 21 mW/cm^2 of a tetracene FET fabricated with SiO_2 gate dielectric. The FET had a channel length of $10 \mu\text{m}$. The measured $|\text{MC}|$ and $|I_{\text{D}}|$ at 200 mT versus the illumination intensity are plotted in Figure 3a. The data show that both $|\text{MC}|$ and $|I_{\text{D}}|$ become larger as the illumination intensity increases. In addition to the illumination intensity, we found that by changing V_{GS} we can tune the $|\text{MC}|$ of the single crystalline tetracene FETs fabricated with SiO_2 gate dielectric even more effectively than for the FETs fabricated with Cytop gate dielectric, see Figure 3b. A large drop in the $|\text{MC}|$ was observed as the magnitude of V_{GS} ($|V_{\text{GS}}|$) increased in the subthreshold region, from 0 V to 10 V . For $|V_{\text{GS}}|$ greater than the threshold voltage ($V_{\text{th}} \approx 5 \text{ V}$), the $|\text{MC}|$ reaches a saturation value at around 0.5% . This is likely because shallow donor (trap) sites are emptied as discussed earlier.

This freedom in using V_{GS} to tune MC allowed us to maximize the MC signal while minimizing noise for electrically probing the changes induced by magnetic field dependent processes in an organic semiconductor. Figure 2b and the inset to Figure 3 show the MC dependence on magnetic field strength. Interestingly, we observe a photo-induced MC feature around 42 mT not previously reported on for MC studies of a thin film based tetracene FETs.²⁷

Previous luminescence and fluorescence spectroscopy studies suggested that singlet fission/triplet fusion processes ($S_0 + S_1 \leftrightarrow T_1 + T_1$) are reversible and they are main sources of magnetic field dependent behavior in tetracene crystals.²⁸ It was suggested that a magnetic field dependence of singlet fission/triplet fusion processes is due to an interplay between the Zeeman effect and intramolecular magnetic (electron spin) dipolar interaction. Given this, we should then expect to observe a dependence of MC on the direction of the applied magnetic field with respect to the crystallographic axes of the tetracene crystal.²⁶

Crystallographic directional dependence of magnetic field effects in the systems with singlet fission was demonstrated in high magnetic field regime (higher than 300 mT) where only two triplet pair states have singlet character, thus being involved in the triplet fusion process. Consequently, the observed anisotropic magnetic field effects were attributed to the level crossing resonance of these two states occurring at a certain crystallographic orientation.²⁶ A theoretical model based on the Zeeman effect and the magnetic dipolar interaction of triplet excitons in a tetracene crystal predicts a crystallographic directional dependence of magnetic field effects due to the energy level crossing also at lower magnetic fields (less than 100 mT). Under an applied external magnetic field, a spin Hamiltonian, H of triplet excitons in molecular crystals can be described by the following equation:³²

$$H = g\mu_B \mathbf{B} \cdot \mathbf{S} + D^* \left[S_z^2 - \frac{S(S+1)}{3} \right] + E^* [S_x^2 - S_y^2] \quad (1)$$

where g is the electron g factor, μ_B is the Bohr magneton, $\mathbf{B}$ is an external magnetic field, $\mathbf{S}$ is the spin operator of an electron of the triplet in units of $\hbar$ (reduced Planck constant), and D^* and E^* are molecular parameters provided by the electron paramagnetic resonance (EPR) measurements.³³ The first term in the equation (1) describes the Zeeman effect and the remaining two terms represent the energy induced by the magnetic dipole-dipole interaction between two electrons in a triplet exciton. The magnetic dipolar interaction is also referred to as zero-field splitting since it lifts the degeneracy of the three triplet states even in the absence of external magnetic fields.¹⁰ The Hamiltonian H can be calculated by using Pauli matrices for the system with spin 1. For the values of D^* and E^* of tetracene crystals, -0.0062 cm^{-1} and 0.0248 cm^{-1} , respectively were obtained in the previous electron paramagnetic resonance (EPR) measurements.³³ The diagonalization of the H produces the three eigenvalues (E_x , E_y , and E_z) and eigenstates ($|x^*\rangle$, $|y^*\rangle$, and $|z^*\rangle$) for a triplet exciton. For two correlated, but non-interacting triplet excitons, the nine triplet pair states can be described as a combination ($E_{a\beta} = E_a + E_\beta$ for the energy and $|a\beta\rangle = |a\rangle| \beta\rangle$ for the spin state, where a and β are either x , y , or z).^{33, 34}

For a tetracene crystal, the molecular x - and z -axes are known to be located in the crystal a - and b - axes plane of the crystal,^{10, 33, 34} which typically corresponds to the largest natural facet of platelet-like crystals.³⁵ The tetracene crystals used in this study are platelet-like and subsequently placed on the prefabricated device substrate as a final process step in fabricating the FET test structures. Thus, in our investigation of singlet fission under an in-plane magnetic field, only two molecular axes, x - and z -axes, need to be examined for the theoretical consideration. In addition, because the nine triplet pair states created by singlet fission are coupled to the initially excited singlet state, only five triplet pair states having a singlet character ($|xx\rangle$, $|yy\rangle$, $|zz\rangle$, $|yz\rangle$, and $|zy\rangle$ for the applied magnetic field along the x -axis and $|xx\rangle$, $|yy\rangle$, $|zz\rangle$, $|xy\rangle$, and $|yx\rangle$ along the z -axis).^{10, 34} Figure 4a and 4b illustrate the magnetic field dependence of calculated energies of these five triplet pair states when the magnetic field is applied along x -axis and z -axis, respectively. As shown in Figure 4a, paired triplet energy states experience an energy level crossing around the magnitude of 42 mT of an external magnetic field applied along the x -axis. However, this energy level crossing disappears when the magnetic field is rotated to the z -axis as shown in Figure 4b.

We carried out angular dependent MC measurements on our tetracene FETs to determine if the features near ± 42 mT we observe in the measured MC response of our tetracene FETs under illumination is due to a change in triplet population *via* triplet sub-energy level crossing as predicted by the theoretical framework presented in the prior section. Specifically, the FET was rotated relative to the in plane magnetic field axis, as described in the top of Figure 5. The feature around 42 mT in the MC response only appeared when the transistor was aligned with the external magnetic field at a specific angle (near $\theta = 0^\circ$) and disappeared as the device was rotated away from that angle as illustrated in Figure 5.

The θ in Figure 5 describes the clockwise rotational angle of the transistor from the original position where the sample axis crossing two electrodes are perpendicular to the applied magnetic field axis. We attribute the shoulder in the $|MC|$ at ≈ 42 mT when the x -axis of the crystal is parallel to the magnetic field direction to the weakening of the magnetic field effects by the degeneracy in triplet pair states as are result of energy level crossing in intermediate paired triplet states created by singlet fission. We note the presence of an additional feature between ± 10 mT in the measured MC response, see Figure 5. As the magnitude of an external magnetic field increases from 0 mT, we observe evidence of weak positive MC before transitioning to negative MC, thus producing a small dip around 0 mT. This weak field positive MC feature is present in the MC response for all measured θ s, but its width is narrower about $\theta = 0^\circ$ than $\theta = 90^\circ$.

To better confirm whether the shoulder features near 42 mT and the weak field positive MC feature are the products of singlet fission/triplet fusion processes, we performed a numerical simulation of the MC by adopting a model proposed by Timmel *et al.*^{36, 37} The excited singlet state responsible for generating nine intermediate triplet pair states in singlet fission process, $|S^1\rangle$ can be described as a superposition of pair product of two triplet states,¹⁰ and thus $|S^1\rangle = (1/\sqrt{3})(|x_0\rangle|x_0\rangle + |y_0\rangle|y_0\rangle + |z_0\rangle|z_0\rangle)$ where $|x_0\rangle$, $|y_0\rangle$, and $|z_0\rangle$ are the eigenstates of the Hamiltonian described in equation (1) when $B = 0$. In general, the singlet fission/triplet fusion processes can be described as

where $(T_1 T_1)$ represents the intermediate triplet pair states, and k_S , k_T , k_{TT} , and k'_{TT} are the rate constants for each process.¹⁰ For our calculation, we considered only the processes involved with k_S and k_T since they are the magnetic field dependent processes.¹⁰ Based on the Liouville-von Neumann equation, the coherent evolution of the excited spin states under the influence of a spin Hamiltonian can be calculated. Assuming the singlet fission rate constant k_S is equal to the triplet fusion rate constant k_T ($k_S = k_T = k$) the steady state yield of excited triplet and singlet states under a magnetic field B , $\Phi_T(B)$ and $\Phi_S(B)$ can be expressed as follows:³⁶

$$\Phi_S(B) = 1 - \Phi_T(B) = \sum_{m=1}^M \sum_{n=1}^M |P_{mn}^S|^2 f(\omega_{mn}) \quad (3)$$

where $f(x) = \frac{k^2}{k^2 + x^2}$, $\omega_{mn} = \frac{E_m - E_n}{\hbar}$, $P_{mn}^S = \langle n | \hat{P}^S | m \rangle$, $\hat{P}^S = |S^1\rangle\langle S^1|$, and M is the total number of triplet pair states (in our case, $M=9$). Furthermore, assuming the steady state triplet pairs created by singlet fission evolve into two triplets contributing to the electrical current, but steady state singlets produced by triplet fusion recombine, MC is described as

$$MC(B) = \frac{\Phi_T(B) - \Phi_T(0)}{\Phi_T(0)} \quad (4)$$

with $\Phi_T(B)$ given by equation (3). Figure 6a and 6b show the simulated MC using equations (3) and (4) as a function of a magnetic field applied along x - and z - axes, respectively. For our calculations, we used $1.0 \text{ (nsec}^{-1}\text{)}$ for k .¹⁰ The calculated MC data suggest that both the dip and the humps can be attributed to singlet fission/triplet fusion processes. When a magnetic field is applied along x -axis, a dip around 0 mT and humps around 42 mT in MC are produced due to sub-energy level crossings in paired triplet states. However, the humps disappear and the width of the dip widens as the magnetic field is rotated and applied along z -axis.

Our simulated curves based on a simplified analytical model capture the salient features of the experimental MC data from single crystalline tetracene FETs in a framework grounded in the physics of magnetic field dependent singlet fission/triplet fusion processes. Details not accurately captured by the simplified model, such as the relative magnitudes of the features around 42 mT and the depth of the dip in calculated MC, are likely to be better captured by using sophisticated models that incorporate more robust rate constants and account for all the magnetic field dependent processes present in the system. For example, a previous study suggested that Wannier-type excited spin states can also be created by absorbing photons along with triplet pair states through singlet fission, and thus the intersystem crossing between Wannier-type triplets and singlets by random hyperfine fields can occur and their relative population can be disturbed by magnetic fields.²⁹ It has been reported that the MC due to the intersystem crossing caused by random hyperfine fields in organic semiconductor based systems can be well fit with either Lorentzian ($B^2/(B_0^2+B^2)$) or non-Lorentzian ($B^2/(B_0+|B|)^2$) equations.^{4, 7} If one adds this empirical non-Lorentzian (or Lorentzian) to our simulated MC curves considering that the Wannier-type excited spin states also contributes to the MC, one may improve the similarity between the simulated and the measured MC response (see Supporting Information).

CONCLUSION

we experimentally demonstrated that a single crystal organic field effect transistor can be used as a more deterministic platform to elucidate the underlying physics of spin-dependent process under magnetic fields than thin film based systems. By using single crystal tetracene FETs, we demonstrate the ability to electrically detect singlet fission/triplet fusion processes under illumination at room temperature along with previously unreported features in the measured magnetoconductance. By considering the nature of singlet fission/triplet fusion processes and magnetic interactions present in tetracene single crystals, we show the unusual

features in MC to originate from triplet sub-energy level crossing under magnetic fields through their related angular dependence on the applied magnetic field. Our findings provide a platform to elucidate the fundamental mechanisms of spin-dependent processes such as singlet fission in organic semiconductors and they also furnish a way in the development of multifunctional magneto-optoelectronic applications.

EXPERIMENTAL METHODS

Preparation of devices.

The FETs were made on two different test beds: Cytop and SiO₂ gate dielectric. One test bed (Cytop) has a bilayer gate dielectric consisting of a 300 nm thick spin coated Cytop (Amorphous Fluoropolymer) layer on top of a 50 nm thick silicon dioxide layer which was thermally grown on a heavily doped silicon substrate (n-type 10⁻³ Ω cm) and photolithographically defined metal electrodes made of 30 nm thick palladium on 5 nm thick titanium. The other test bed (SiO₂) is composed of a single 200 nm thick thermally grown silicon dioxide layer as a gate dielectric and photolithographically defined metal electrodes made of 40 nm thick platinum on 2 nm thick titanium. Tetracene single crystals were grown by physical vapor transport in a tube oven under argon flow. The crystals were carefully laminated to the surface of the test beds, completing the FET fabrication process. Thickness of crystals used for the study are on the order of 0.7 microns, and the light absorption through the crystals should be approximately the same. The two photolithographically defined metal electrodes were biased as the source and drain contact of the FET. The heavily doped silicon substrate was contacted from the wafer back side to form gate contact. The single crystal tetracene FETs had channel lengths that ranged from 5 μm to 100 μm. A self-assembled monolayer of octadecyltrichlorosilane was used to improve the semiconductor adhesion and create a hydrophobic surface on the SiO₂ that limits adsorbed water at the FET channel interface for the test beds with a single SiO₂ gate dielectric layer.^{38,39}

Electrical measurements.

Electrical and magnetic field measurements were carried out at room temperature in a commercially available probe station with an attached electromagnet. The measurements were performed under a nitrogen gas environment to minimize possible device degradation and hysteresis in the electrical characteristics. The devices were illuminated by a commercial fiber optic illuminator and through the glass window of the probe station. The illumination intensity was measured with a commercial silicon photodiode. Our fiber optic illuminator has a spectrum of wavelengths that range from ≈350 nm to ≈1400 nm, and thus it is expected to allow the light only in that range of wavelengths to reach the devices. During magnetic field measurements and with applied constant bias voltages, we observed some linear drift in the measured current and corrected for tilt when plotting magnetoconductance.

Supplementary Material

Refer to Web version on PubMed Central for supplementary material.

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Figure 1.

Device structure and electrical characteristics of a single crystal tetracene FET fabricated with Cytop gate dielectric. (a) Magnitude of drain current, $|I_D|$ versus gate-source voltage (V_{GS}) of a single crystal tetracene FET (Cytop gate dielectric) measured at a drain-source voltage (V_{DS}) of -1 V (black lines) and -20 V (red lines), and square root of I_D versus V_{GS} at $V_{DS} = -20\text{ V}$ (saturation regime) (magenta lines). Dark measurements are indicated by solid lines; measurements made under illumination are indicated by dashed lines. Inset: schematic view of a single crystal tetracene FET and illustration of the electrical and the

magnetic field measurement setups. (b) Magnitude of magnetoconductance ($|MC|$) at a magnetic field of approximately 200 mT *versus* the magnitude of V_{GS} measured in the dark (black filled squares) and under illumination (red open circles), $|V_{GS}|$. Inset: MC measured by sweeping an external magnetic field between 230 mT and -230 mT measured under illumination (red line) and in the dark (black line) for $V_{DS} = -1$ V and $V_{GS} = -2$ V.

Figure 2.

Electrical characteristics of a single crystal tetracene FET fabricated with SiO_2 gate dielectric. (a) Magnitude of drain current ($|I_D|$) versus gate-source bias (V_{GS}) of a single crystal tetracene FET (SiO_2 gate dielectric) measured at a drain-source voltage (V_{DS}) of -1 V (black lines) and -40 V (red lines), and square root of I_D versus V_{GS} at $V_{DS} = -40$ V (saturation regime) (magenta lines) in the dark (solid lines) and under illumination (dashed lines). Hysteresis in $|I_D|$ is evidence for charge trapping: for the forward sweep direction (V_{GS} from 0 V to -40 V), $|I_D|$ is higher than that for the reverse sweep (V_{GS} from -40 V to

0 V) for all measurements. (b) Change in $|I_D|$ measured by sweeping the external magnetic field between 230 mT and -230 mT under illumination (red line) and in the dark (black line) for $V_{DS} = -20$ V and $V_{GS} = -2.5$ V.

Figure 3.

Magnetoconductance and drain current of a single crystal tetracene FET fabricated with SiO_2 gate dielectric. Magnitude of magnetoconductance ($|MC|$) measured at a magnetic field of approximately 200 mT (black filled squares) and the magnitude of I_D ($|I_D|$) (blue open circles) versus (a) illumination intensity and (b) the magnitude of V_{GS} ($|V_{GS}|$). Inset to figure 3a: MC measured under illumination (red line) and in the dark (black line) with $V_{DS} = -20$ V and $V_{GS} = -2.5$ V. Inset to figure 3b: MC measured with $V_{GS} = -2.5$ V (black line) and -25 V (red line) under the illumination and with $V_{DS} = -20$ V. $|MC|$ and $|I_D|$ in the

plot are the mean of the values of $|MC|$ and $|I_D|$, respectively at -200 mT and 200 mT. Error bars give the standard deviation of the mean.

Figure 4.

Calculated magnetic field dependence of triplet pair state energy. Magnetic field dependence of triplet pair state energies (for pair states having a singlet character) when the magnetic field is applied along the (a) x -axis and (b) z -axis directions. Inset to (a): Calculated triplet pair state energy *versus* magnetic field plotted for a narrower range around the level crossing point at approximately 42 mT.

Figure 5.

Angular dependence of magnetoconductance. Schematic illustration of the FET orientation to the applied magnetic field axis (top) and the measured MC response for different orientations of the FET (a - and b - axes plane of the tetracene crystal) to the magnetic field axis. Orientation angle is indicated as θ . As indicated, the sample axis is defined as the axis vertically crossing two parallel electrodes. To set the field orientation, the sample axis was rotated. Angle between the crystal b -axis and the sample axis was around 2° and the crystal a -axis was perpendicular to the crystal b -axis (see Supporting Information).

Figure 6. Simulated magnetoconductance. MC response simulated for the singlet fission/triplet fusion processes in single crystal tetracene FETs with the magnetic field applied along (a) x -axis and (b) z -axis directions. Since x - and z -axes are closely aligned with the crystal a - and b -axes, respectively, the simulated MC curves plotted in (a) and (b) correspond to the measured MC curves of around $\theta = 0^\circ$ and 90° of figure 5, respectively.